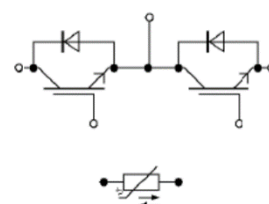


1200V/600A 2 in one-package

Features:

- 1200V600A, $V_{CE(sat)}(typ.)=2.20V$
- Lower losses and higher energy
- Excellent short circuit ruggedness
- Standard Housing



General Applications:

H&M Semi's IGBTs offer lower losses and higher energy for application such as motor drive ,inverter and other soft switching applications.soft switching applications.

Equivalent Circuit Schematic

Absolute Maximum Ratings of IGBT

Parameter			Values	Unit
V_{CES}	Collector to Emitter Voltage		1200	V
V_{GES}	Continuous Gate to Emitter Voltage		± 30	V
I_C	Continuous Collector Current	$T_C = 25^\circ C$	1200	A
		$T_C = 80^\circ C$	600	
I_{CM}	Pulse Collector Current	$T_J = 150^\circ C$	600	A
P_D	Maximum Power Dissipation (IGBT)	$T_C = 25^\circ C,$	1470	W
		$T_J = 150^\circ C$		
t_{sc}	Short Circuit Withstand Time		> 10	μs
T_J	Maximum IGBT Junction Temperature		150	$^\circ C$
T_{JOP}	Maximum Operating Junction Temperature Range		-40 to +150	$^\circ C$
T_{stg}	Storage Temperature Range		-40 to +125	$^\circ C$

Absolute Maximum Ratings of Freewheeling Diode

V_{RRM}	Repetitive Peak Reverse Voltage	$T_{vj} = 25^\circ C$	1200	V
I_F	Diode Continuous Forward Current	$T_{vmax} = 150^\circ C$	600	A
I_{FM}	Diode Maximum Forward Current	$t_p = 1ms$	1200	A
I^2t	I^2t Value	$V_r=0V, t_p=10ms, T_{vj}=125^\circ C$	45000	A^2S
		$V_r=0V, t_p=10ms, T_{vj}=150^\circ C$	42000	

Electrical Characteristics of IGBT at $T_J = 25^\circ\text{C}$ (Unless Otherwise Specified)

Parameter		Test Conditions		Min	Typ	Max	Unit
BV_{CES}	Collector to Emitter Breakdown Voltage	$V_{GE}=0V, T_J=25^\circ\text{C}$		1200			V
I_{CES}	Collector-emitter cut-off current t	$V_{GE}=0V, V_{CE}=1200V, T_J=25^\circ\text{C}$				3	mA
I_{GES}	Gate to Emitter Leakage Current	$V_{GE}=\pm 30V, V_{CE}=0V, T_J=25^\circ\text{C}$				400	nA
$V_{GE(th)}$	Gate Threshold Voltage	$I_C=20mA, V_{CE}=V_{GE}, T_J=25^\circ\text{C}$		5.0		6.0	V
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage (Module Level)	$I_C=600A,$ $V_{GE}=15V$	$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		2.20 2.40	2.40	V

Switching Characteristics of IGBT

Parameter		Test Conditions		Min	Typ	Max	Unit
$t_{d(on)}$	Turn-on Delay Time	$V_{CC} = 600V$ $I_C = 600A$ $R_G = 1.5\Omega$ $V_{GE} = \pm 15V$ Inductive Load	$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		330 340		ns
t_r	Turn-on Rise Time		$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		135 125		ns
$t_{d(off)}$	Turn-off Delay Time		$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		550 610		ns
t_f	Turn-off Fall Time		$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		90 115		ns
E_{on}	Turn-on Switching Loss		$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		40 55		mJ
E_{off}	Turn-off Switching Loss		$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		65 85		mJ
Q_g	Total Gate Charge	$V_{GE} = -15V \rightarrow +15V$	$T_J=25^\circ\text{C}$		4.8		uC
R_{gint}	Integrated gate resistor		$T_J=25^\circ\text{C}$		2.37		Ω
C_{ies}	Input Capacitance	$V_{CE}=25V$ $V_{GE}=0V$ $f=1MHz$	$T_J=25^\circ\text{C}$		82		nF
C_{oes}	Output Capacitance		$T_J=25^\circ\text{C}$		4.1		
C_{res}	Reverse Transfer Capacitance		$T_J=25^\circ\text{C}$		1.8		
I_{SC}	SC data	$V_{GE} \leq 15V, V_{CC}=600V$ $V_{CEmax}=V_{CES}-L_{sCE} \cdot di/dt$	$T_J=125^\circ\text{C}$		3600		A
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case (IGBT)					0.085	$^\circ\text{C/W}$

Electrical and Switching Characteristics of Freewheeling Diode

Parameter		Test Conditions		Min	Typ	Max	Unit
V _F	Diode Forward Voltage	I _F =600A , V _{GE} =0V	T _J =25C T _J =125C		2.20 2.40	2.40	V
I _{rr}	Diode Peak Reverse Recovery Current	I _F =600A, di/dt= 4200A/μs, V _R =600V, V _{GE} -15V	T _J =25C T _J =125C		255 310		A
Q _{rr}	Diode Reverse Recovery Charge		T _J =25C T _J =125C		27 55		uC
E _{rec}	Diode Reverse Recovery Energy		T _J =25C T _J =125C		14 25		mJ
R _{θJC}	Thermal Resistance, Junction-to-Case (Diode)					0.141	°C/W

Characteristic Values of NTC-Thermistor

Parameter	Test Conditions	Min	Typ	Max	Unit
R_{25}	$T_{NTC}=25^{\circ}C$		5		k Ω
$\Delta R/R$	$T_{NTC}=100^{\circ}C$, $R_{100}=481\Omega$	-5		5	%
P_{25}	$T_{NTC}=25^{\circ}C$			20	mW
$B_{25/50}$	$R_2=R_{25} \exp[B_{25/50}(1/T_2-1/(298.15K))]$		3380		K
$B_{25/80}$	$R_2=R_{25} \exp[B_{25/80}(1/T_2-1/(298.15K))]$		3440		K

Module Characteristics

Parameter		Min.	Typ.	Max.	Unit
V_{iso}	Isolation Voltage(All Terminals Shorted) Terminals to base plate,RMS,f=50Hz,AC 1min	2500			V
$R_{\theta CS}$	Case-To-Sink,per 1 module,Thermal grease applied		0.02		$^{\circ}C/W$
L_{sCE}	Stray inductance module		20		nH
$R_{CC'+EE'}$	Internal lead resistance,Main terminals-chip,per switch, $T_c=25^{\circ}C$		1		m Ω
M_t	Main terminals M6 Screw	3.0	4.0	5.0	N·m
M_s	Mounting to heat sink M5 Screw	3.0	4.0	5.0	N·m
G	Weight		345		g

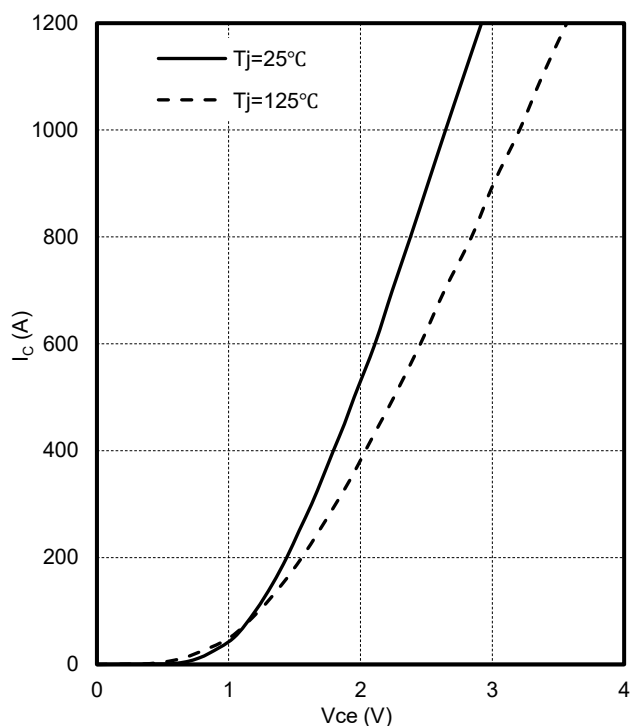


Fig.1 Output characteristic IGBT,
 $I_C=f(V_{ce}), V_{ge}=15V$

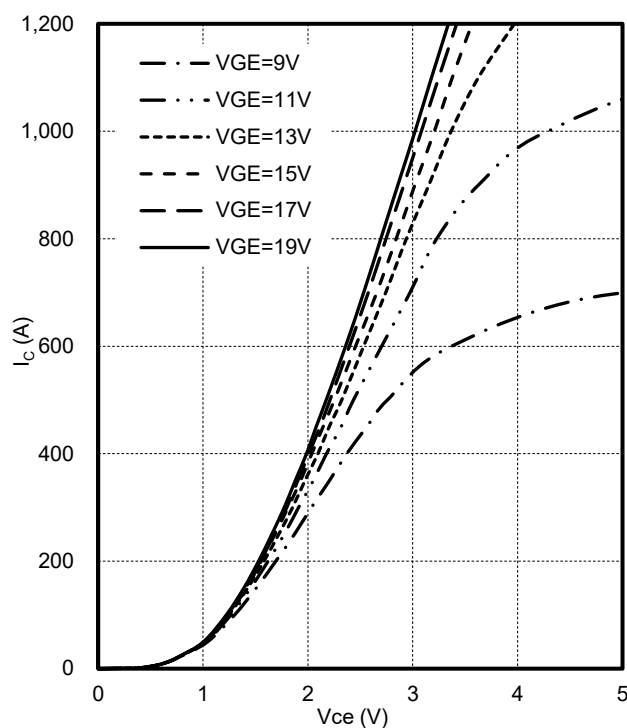


Fig.2 Output characteristic IGBT,
 $I_C=f(V_{ce}), T_j=125^\circ C$

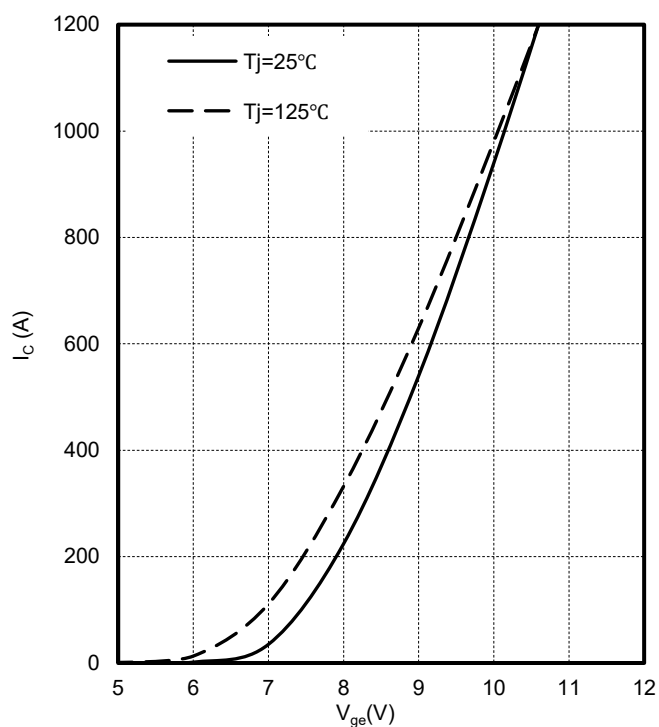


Fig.3 Transfer characteristic IGBT,
 $I_C=f(V_{ge}), V_{ce}=20V$

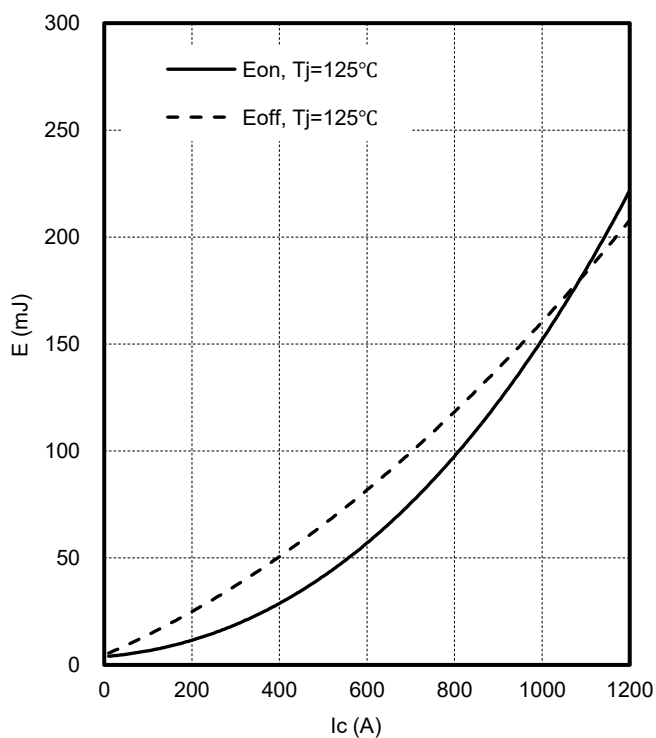


Fig.4 Switching losses IGBT, $E_{on}=f(I_C), E_{off}=f(I_C)$,
 $V_{ge}=\pm 15V, R_{gon}=1.5\Omega, R_{goff}=1.5\Omega, V_{ce}=600V$

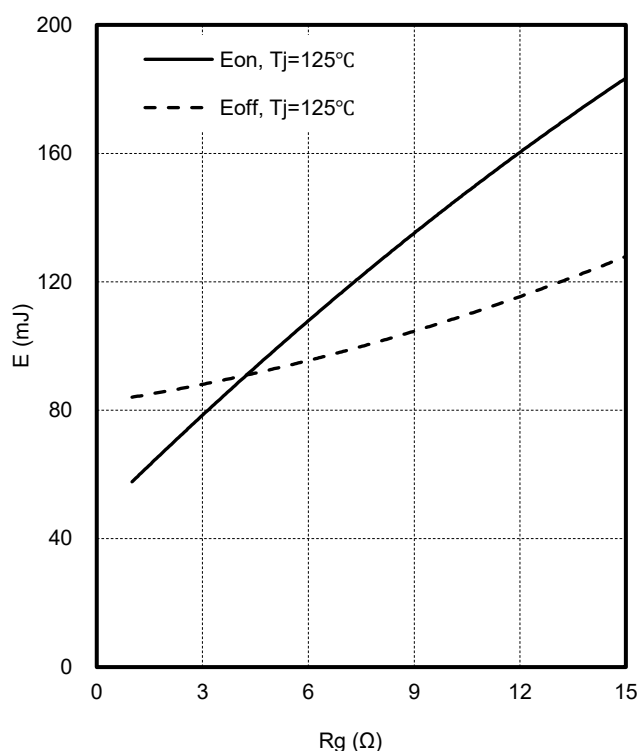


Fig.5 Switching losses IGBT, $E_{on}=f(R_g)$, $E_{off}=f(R_g)$, $V_{ge}=\pm 15\text{V}$, $I_c=600\text{A}$, $V_{ce}=600\text{V}$

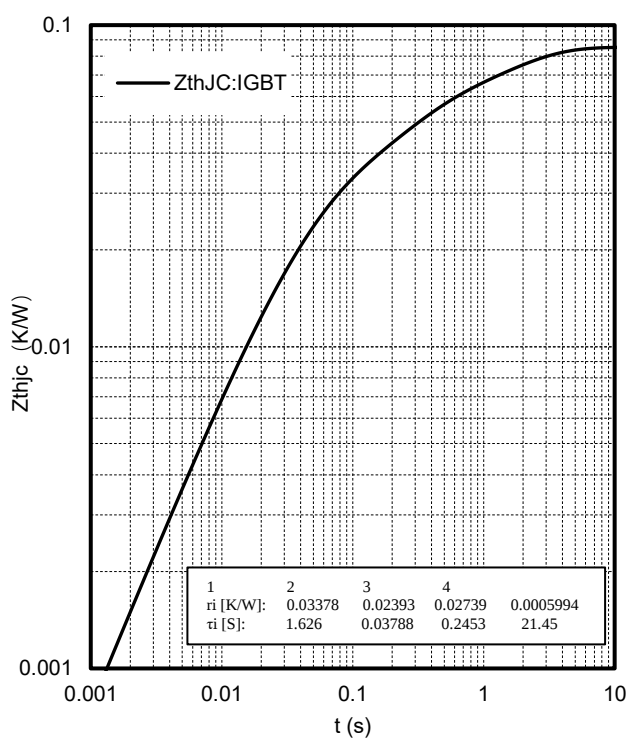


Fig.6 Transient thermal impedance IGBT, $Z_{thjc}=f(t)$

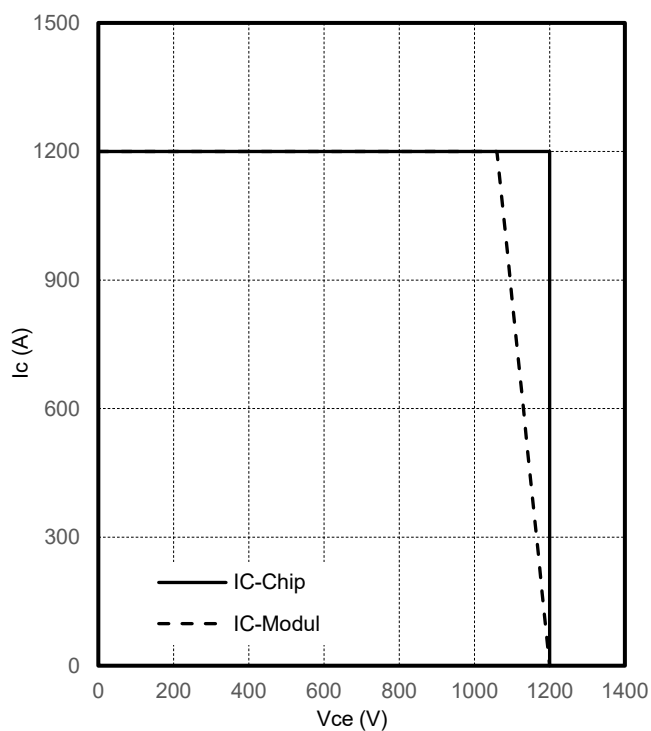


Fig.7 Reverse bias safe operating area IGBT, $I_c=f(V_{ce})$, $V_{ge}=\pm 15\text{V}$, $R_{goff}=1.5\Omega$, $T_{vj}=125^\circ\text{C}$

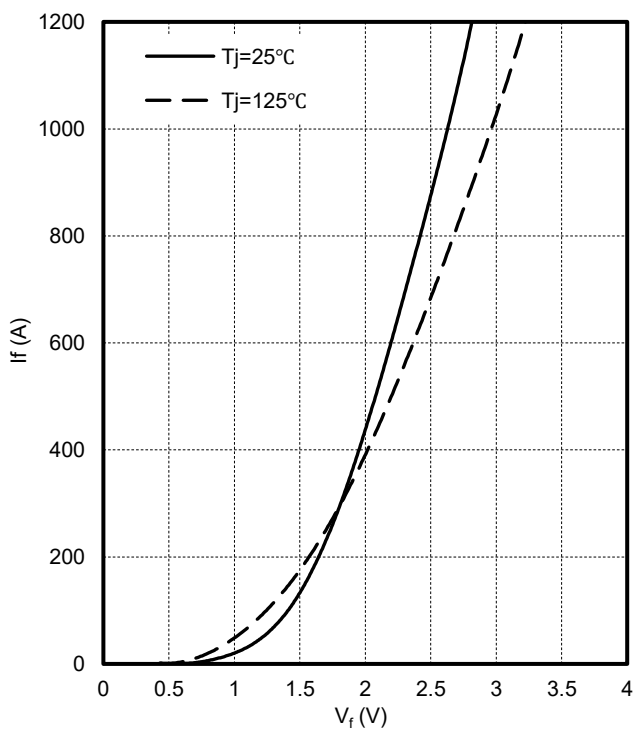


Fig.8 Forward characteristic of Diode, $I_f=f(V_f)$

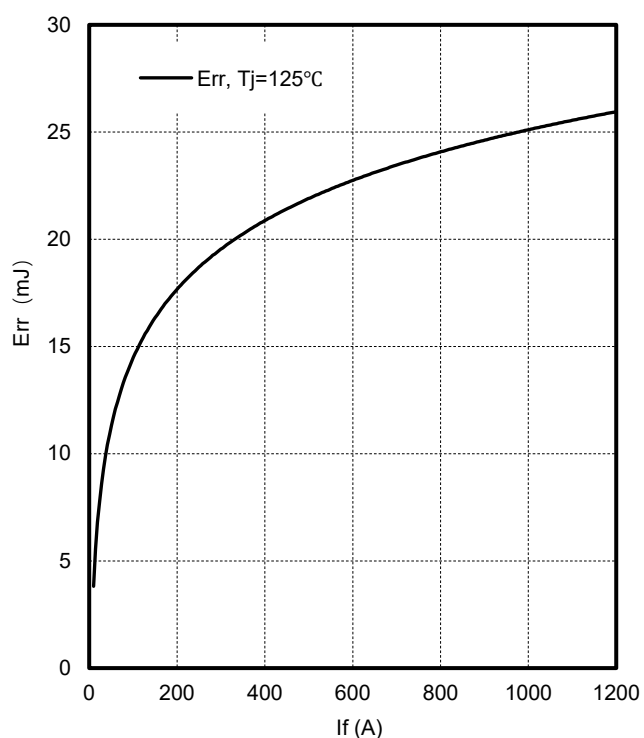


Fig.9 Switching losses Diode,
 $Err=f(I_f), R_{gon}=1.5\Omega, V_{ce}=600V$

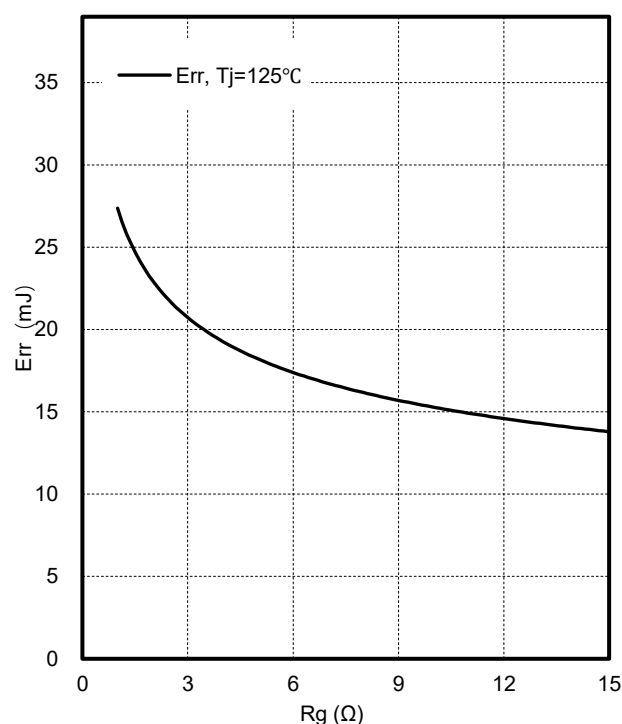


Fig.10 Switching losses Diode,
 $Err=f(R_g), I_f=600A, V_{ce}=600V$

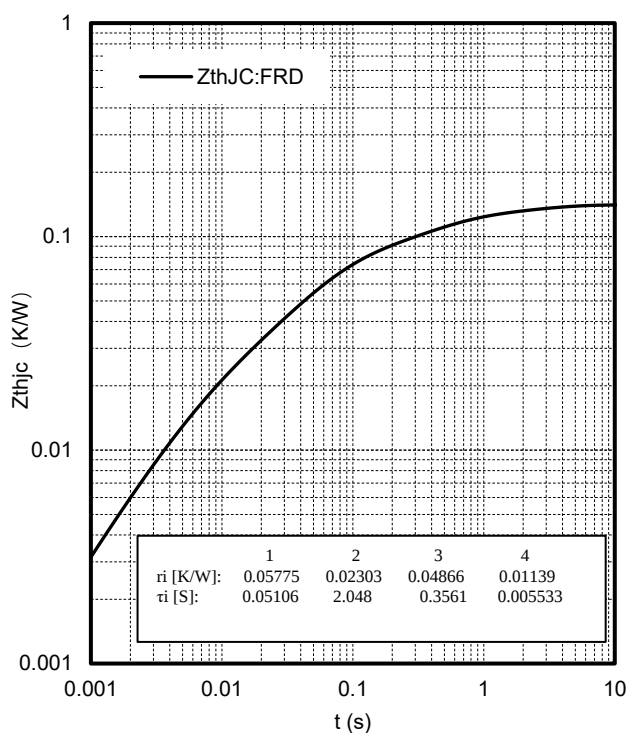


Fig.11 Transient thermal impedance Diode,
 $Z_{thjc}=f(t)$

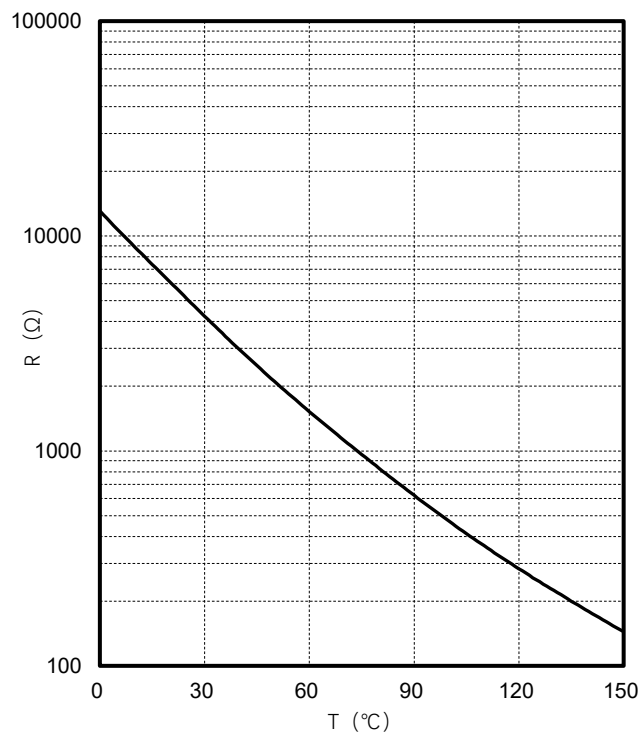
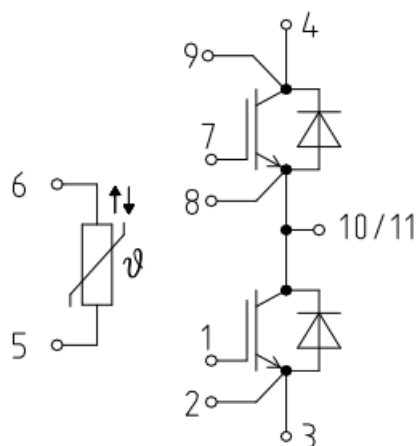


Fig.12 NTC-Thermistor-temperature
characteristic(typical)

Internal Circuit:



Package Dimension Dimensions in Millimeters

